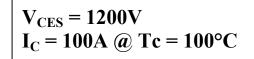
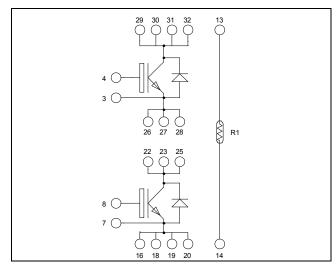
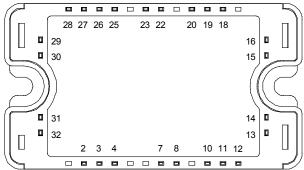


## Phase leg High speed Trench + Field Stop IGBT4 Power Module







Pins 29/30/31/32 must be shorted together Pins 26/27/28/22/23/25 must be shorted together to achieve a phase leg Pins 16/18/19/20 must be shorted together

#### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### **Features**

- High speed Trench + Field Stop IGBT 4 Technology
  - Low voltage drop
  - Low leakage current
  - Low switching losses
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring
- AIN substrate for improved thermal performance

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive TC of VCEsat
- Each leg can be easily paralleled to achieve a phase leg of twice the current capability
- RoHS compliant

### All ratings @ $T_i = 25$ °C unless otherwise specified

#### Absolute maximum ratings (per IGBT)

Symbol	Parameter		Max ratings	Unit
$V_{CES}$	Collector - Emitter Voltage		1200	V
Ţ	Continuous Collector Current	$T_C = 25^{\circ}C$	185	
$I_{C}$	Continuous Collector Current $T_C = 10$		100	Α
$I_{CM}$	Pulsed Collector Current	$T_C = 25^{\circ}C$	375	
$V_{GE}$	Gate – Emitter Voltage		±20	V
$P_{D}$	Maximum Power Dissipation		650	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 150^{\circ}C$	200A @ 1100V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



**Electrical Characteristics** (per IGBT)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 1200V$				50	μΑ
V	Collector Emitter Saturation Voltage	, GE 10 ,	$T_j = 25$ °C	1.7	2.05	2.4	V
$V_{CE(sat)}$			$T_{j} = 150^{\circ}C$		2.6		V
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 3.8 \text{ mA}$		5.0	5.8	6.5	V
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				150	nA

**Dynamic Characteristics** (per IGBT)

•	Characteristic	Test Conditions	Min	Тур	Max	Unit
$C_{ies}$	Input Capacitance	$V_{GE} = 0V$		6150		
$C_{oes}$	Output Capacitance	$V_{CE} = 25V$		350		pF
$C_{res}$	Reverse Transfer Capacitance	f = 1MHz		300		
$Q_{G}$	Gate charge	$V_{GE} = 15V, I_{C} = 100A$ $V_{CE} = 960V$		450		nC
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C	)	30		
$T_{r}$	Rise Time	$V_{GE} = \pm 15V$		57		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 100A$		290		ns
$T_{\mathrm{f}}$	Fall Time	$R_G = 5\Omega$		16		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C	C)	30		
$T_{r}$	Rise Time	$V_{GE} = \pm 15V$		49		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 100A$		366		ns
$T_{\mathrm{f}}$	Fall Time	$R_G = 5\Omega$		48		
E	Turn on Engage	$V_{GE} = \pm 15V$ $T_i = 25^{\circ}C$	,	7.7		
Eon	Turn on Energy	$V_{Bus} = 600V$ $T_i = 150^{\circ}$	2	9		mJ
Б	Turn off Energy	$I_C = 100A$ $T_i = 25^{\circ}C$	1	2.9		1113
$E_{off}$	Turn off Energy	$R_G = 5\Omega$ $T_j = 150^{\circ}$	2	5.4		
$I_{sc}$	Short Circuit data	$V_{GE} \le 15V$ ; $V_{Bus} = 900V$ $t_p \le 10\mu s$ ; $T_j = 150$ °C		350		A
$R_{thJC}$	Junction to Case Thermal Resistance				0.23	°C/W

**Diode ratings and characteristics** (per diode)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$V_{RRM}$	Peak Repetitive Reverse Voltage					1200	V
$I_{RM}$	Reverse Leakage Current	V <sub>R</sub> =1200V				150	μΑ
$I_F$	DC Forward Current		$Tc = 80^{\circ}C$		120		A
		$I_F = 120A$			2.6	3	
$V_{\mathrm{F}}$	Diode Forward Voltage	$I_{\rm F} = 240 A$			3		V
		$I_F = 120A$	$T_{j} = 125^{\circ}C$		1.8		
+	Reverse Recovery Time	3	$T_j = 25$ °C		265		nc
$t_{rr}$		$I_{\rm F} = 120 A$	$T_{j} = 125^{\circ}C$		350		ns
Q <sub>rr</sub>	Reverse Recovery Charge	$\begin{array}{c} V_{R} = 800V \\ di/dt = 400A/\mu s \end{array}$	$T_j = 25$ °C		1120		пC
			$T_{j} = 125^{\circ}C$		5780		пС
$R_{thJC}$	Junction to Case Thermal Resistance	•				0.37	°C/W



## $Temperature\ sensor\ NTC\ (\text{see application note APT0406 on www.microsemi.com}).$

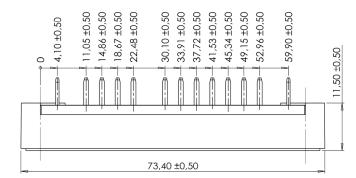
Symbol	Characteristic		Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta \mathrm{B/B}$		$T_C=100$ °C		4		%

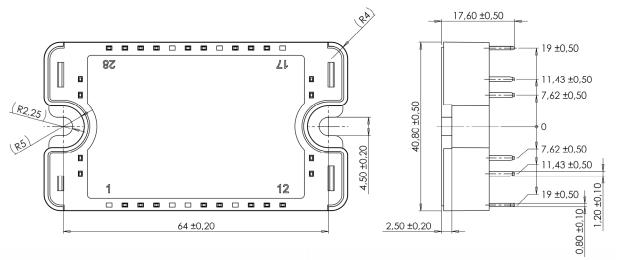
$$R_T = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature}$$
 
$$R_T: \text{ Thermistor value at T}$$

### Thermal and package characteristics

Symbol	l Characteristic				Max	Unit
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz					V
$T_{\mathrm{J}}$	Operating junction temperature range				175	
$T_{JOP}$	Recommended junction temperature under switching conditions				T <sub>J</sub> max -25	°C
$T_{STG}$	Storage Temperature Range				125	C
$T_{\rm C}$	Operating Case Temperature				100	
Torque	Mounting torque	To heatsink M4		2	3	N.m
Wt	Package Weight				110	g

### Package outline (dimensions in mm)



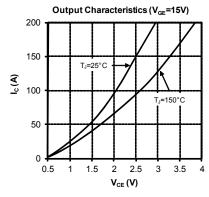


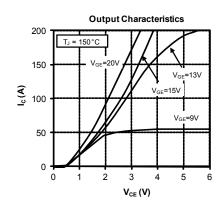
See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

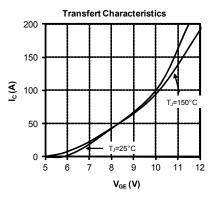
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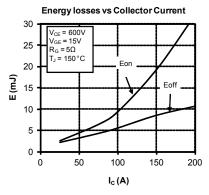


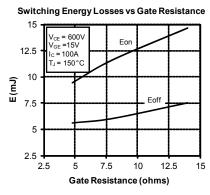
### Typical performance curve

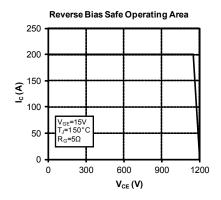


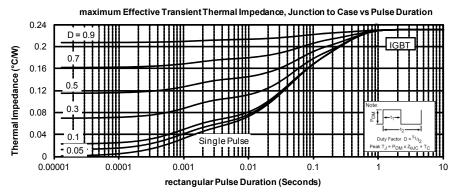




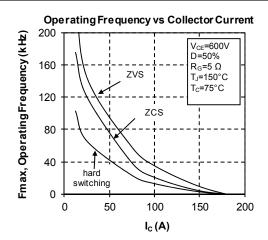


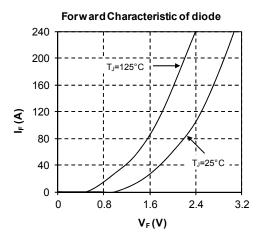




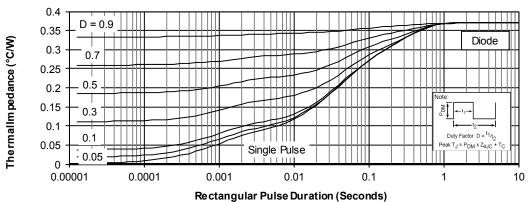








#### maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration





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